

Search Notes

Application/Control No.

10/808,067

Examiner

Aaron M. Dunwoody

Applicant(s)/Patent under
Reexamination

MIKIYA ET AL.

Art Unit

3679

SEARCHED

Class	Subclass	Date	Examiner
updated	searcj	6/12/2006	AMD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR